MBQ50T65FDSC

650V Field Stop IGBT

General Description

This IGBT is produced using advanced MagnaChip's Field Stop Trench IGBT Technology, which provides high switching series and excellent quality.

This device is for PFC, UPS & Inverter applications.

Features

- High Speed Switching & Low Power Loss
- $V_{CE(sat)}$ = 1.95V @ I_C = 50A
- E_{off} = 0.37mJ @ T_C = 25°C
- High Input Impedance
- t_{rr} = 80ns (typ.) @di_F/dt = 1000A/ μs
- Maximum junction temperature 175°C

Applications

- PFC
- UPS
- PV Inverter
- Welder
- IH Cooker

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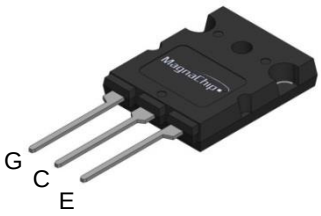

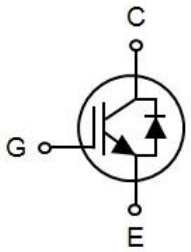

Maximum Rating

Parameter		Symbol	Rating	Unit
Collector-emitter voltage		V_{CE}	650	V
DC collector current, limited by T_{vjmax}	T_C=25°C	I_C	100	A
	T_C=100°C		50	A
Pulsed collector current, t_p limited by T_{jvjmax}		I_{Cpuls}	200	A
Turn off safe operating area $V_{CE} \leq$ 650V, $T_{vj} \leq$ 175°C		-	200	A
Diode forward current limited by T_{vjmax}	T_C=25°C	I_F	60	A
	T_C=100°C		30	
Diode pulsed current, t_p limited by T_{vjmax}		I_{Fpuls}	200	A
Gate-emitter voltage		V_{GE}	±20	V
Power dissipation	T_C=25°C	P_D	273	W
	T_C=100°C		136	W
Short circuit withstand time $V_{CC} \leq$ 400V, V_{GE} = 15V, T_{vj} = 150°C Allowed number of short circuits < 1000 Time between short circuits $\geq$ 1.0s		tsc	5	μs
Operating Junction temperature range		T_{vj}	-40~175	°C
Storage temperature range		T_{stg}	-55~150	°C
Soldering temperature Wave soldering 1.6 mm (0.063 in.) from case for 10s			260	°C
Mounting torque, M3 screw Maximum of mounting processes: 3		M	0.6	Nm

Thermal Characteristic

Parameter	Symbol	Rating	Unit
Thermal resistance junction-to-ambient	$R_{\theta JA}$	40	°C/W
Thermal resistance junction-to-case for IGBT	$R_{\theta JC}$	0.55	
Thermal resistance junction-to-case for Diode	$R_{\theta JC}$	1.2	

Ordering Information

Part Number	Marking	Temp. Range	Package	Packing	RoHS Status
MBQ50T65FDSCTH	50T65FDSC	-55~175°C	TO-247	Tube	Halogen Free

Electrical Characteristic (T_{vj} = 25°C unless otherwise specified)

Parameter	Symbol	Conditions		Min	Typ	Max	Unit
Static Characteristic							
Collector-emitter breakdown voltage	BV_{CES}	I_C = 2mA, V_{GE} = 0V		650	-	-	V
Collector-emitter saturation voltage	$V_{CE(sat)}$	I_C = 50A, V_{GE} = 15V, T_{vj} = 25°C			1.95	2.4	V
		I_C = 50A, V_{GE} = 15V, T_{vj} = 175°C			2.35		
Diode forward voltage	V_F	V_{GE} = 0V, I_F = 30A	T_{vj} = 25°C		1.65	2.05	V
			T_{vj} = 125°C		1.55		
			T_{vj} = 175°C		1.45		
Gate-emitter threshold voltage	$V_{GE(th)}$	V_{CE} = V_{GE}, I_C = 0.5mA		3.8	5.0	6.2	V
Zero gate voltage collector current	I_{CES}	V_{CE} = 650V, V_{GE} = 0V	T_{vj} = 25°C	-	-	40	μA
			T_{vj} = 175°C	-	-	1000	
Gate-emitter leakage current	I_{GES}	V_{GE} = 20V, V_{CE} = 0V		-	-	±100	nA
Transconductance	g_{fs}	V_{CE} = 20V, I_C = 50A,			23.5		S
Dynamic Characteristic							
Total gate charge	Q_g	V_{CE} = 520V, I_C = 50A, V_{GE} = 15V		-	293		nC
Gate-emitter charge	Q_{ge}			-	47		
Gate-collector charge	Q_{gc}			-	160		
Input capacitance	C_{ies}	V_{CE} = 25V, V_{GE} = 0V, f = 1MHz		-	4453	-	pF
Reverse transfer capacitance	C_{res}			-	161	-	
Output capacitance	C_{oes}			-	238	-	
Internal emitter inductance measured 5mm (0.197 in.) from case	L_E			-	13.0	-	nH
Short circuit collector current Max. 1000 short circuits Time between short circuits: ≥ 1.0s	$I_{C(SC)}$	V_{GE} = 15V, V_{CC} = 400V, t_{SC} ≤ 5μs, T_{vj} = 150°C		-	150	-	A
Switching Characteristic							
Turn-on delay time	$t_{d(on)}$	V_{GE} = 15V, V_{CC} = 400V, I_C = 50A, R_G = 7Ω, Inductive Load, T_{vj} = 25°C		-	48	-	ns
Rise time	t_r			-	60	-	
Turn-off delay time	$t_{d(off)}$			-	344	-	
Fall time	t_f			-	40	-	
Turn-on switching energy	E_{on}			-	1.4	-	mJ
Turn-off switching energy	E_{off}			-	0.37	-	
Total switching energy	E_{ts}			-	1.77	-	
Reverse recovery time	t_{rr}	I_F = 30A, di_F/dt = 1000A/ μs, T_{vj} = 25°C		-	80	-	ns
Reverse recovery current	I_{rr}			-	24	-	A
Reverse recovery charge	Q_{rr}			-	0.9	-	μC
Rate of fall of reverse recovery current during t_b	di_{rr}/dt			-	-1050	-	A/μs

Switching Characteristic

Turn-on delay time	$t_{d(on)}$	V_{GE} = 15V, V_{CC} = 400V, I_C = 50A, R_G = 7Ω, Inductive Load, T_{vj} = 175°C	-	38	-	ns
Rise time	t_r		-	69	-	
Turn-off delay time	$t_{d(off)}$		-	366	-	
Fall time	t_f		-	33	-	
Turn-on switching energy	E_{on}		-	2.1	-	mJ
Turn-off switching energy	E_{off}		-	0.4	-	
Total switching energy	E_{ts}		-	2.5	-	
Reverse recovery time	t_{rr}	I_F = 30A, di_F/dt = 1000A/ μs, T_{vj} = 175°C	-	148	-	ns
Reverse recovery current	I_{rr}		-	42	-	A
Reverse recovery charge	Q_{rr}		-	3.1	-	nC
Rate of fall of reverse recovery current during t_b	di_{rr}/dt		-	-510	-	A/μs

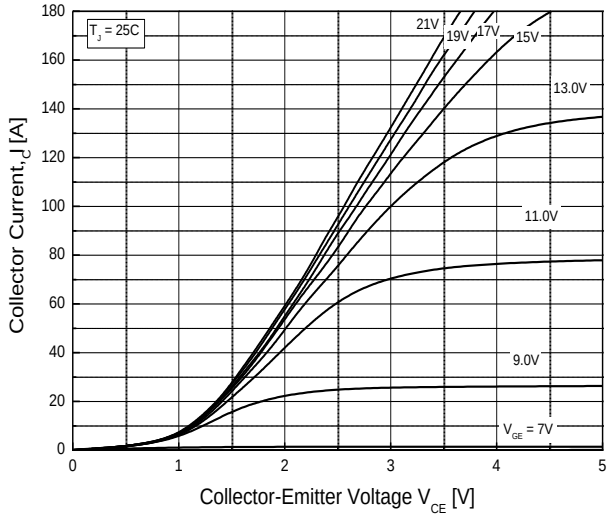

Fig.1 Typical Output Characteristics(T_J=25℃)

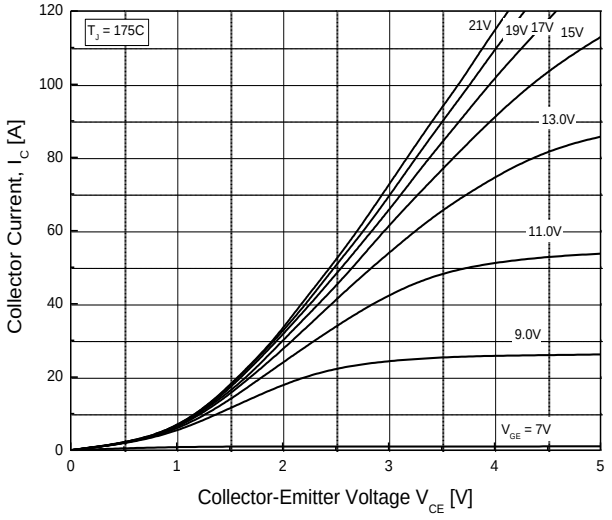

Fig.2 Typical Output Characteristics(T_J=175℃)

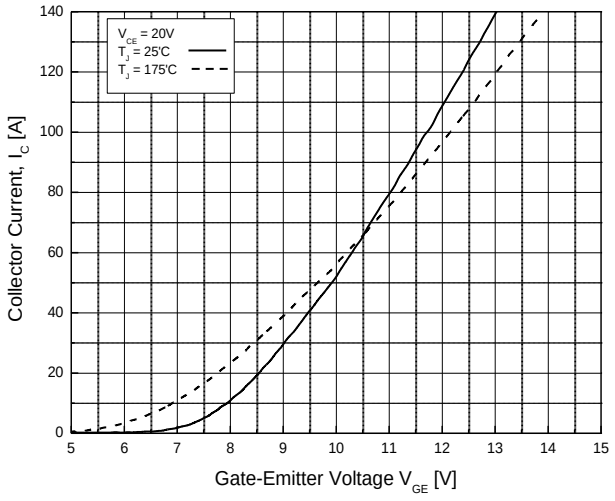

Fig.3 Typical Transfer Characteristics

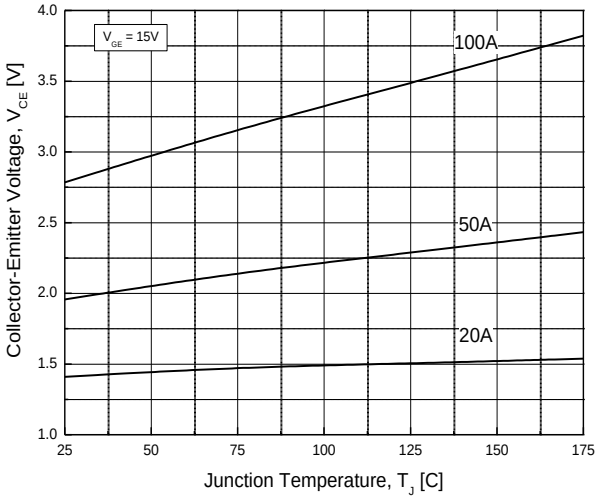

Fig.4 Typical Collector-Emitter Saturation Voltage -Junction Temperature

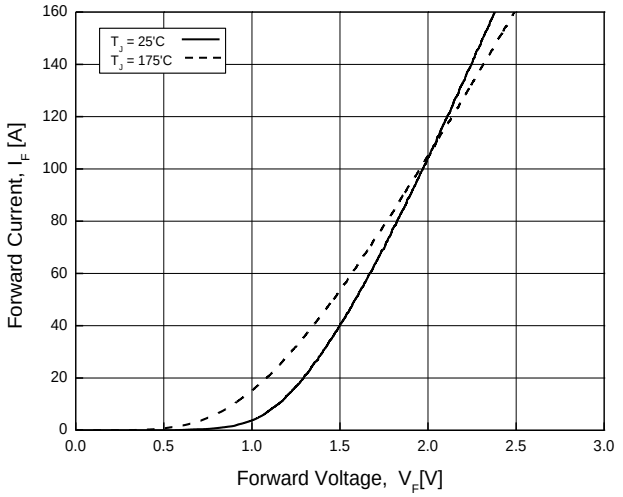

Fig.5 Diode Forward Characteristics

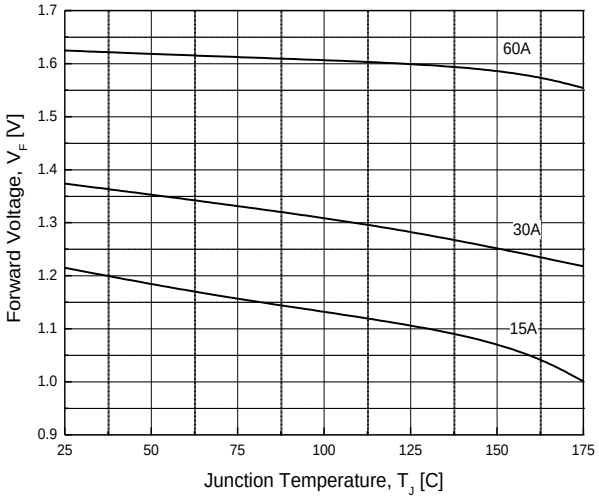

Fig.6 Diode Forward-Junction Temperature

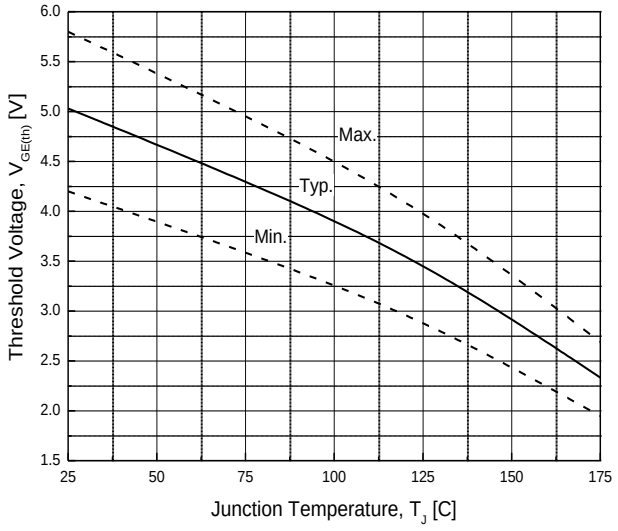

Fig.7 Threshold Voltage-Junction Temperature

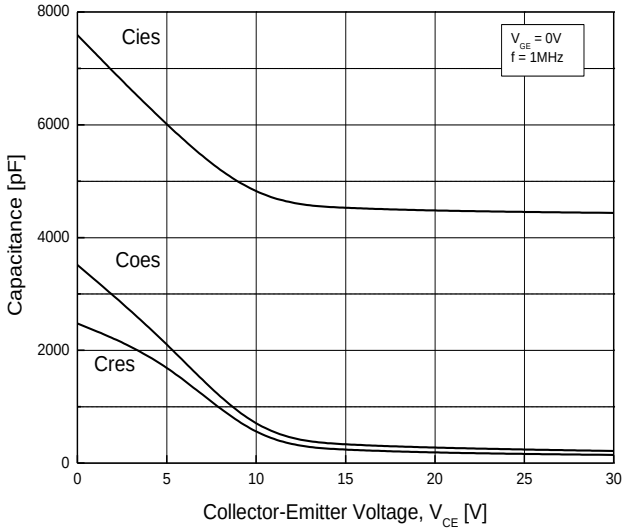

Fig.8 Typical Capacitance

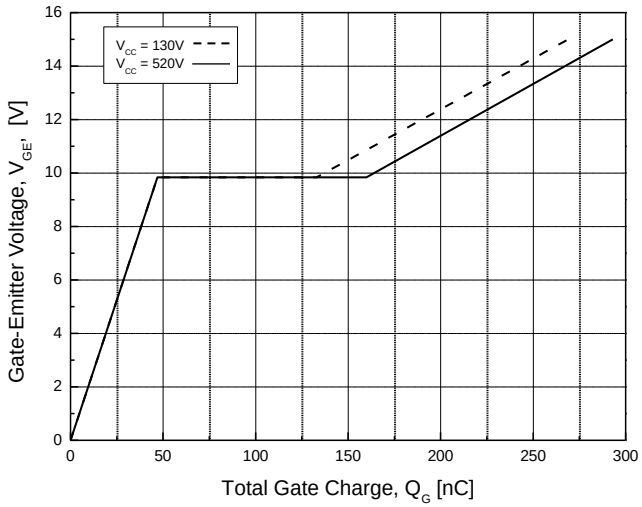

Fig.9 Typical Gate Charge

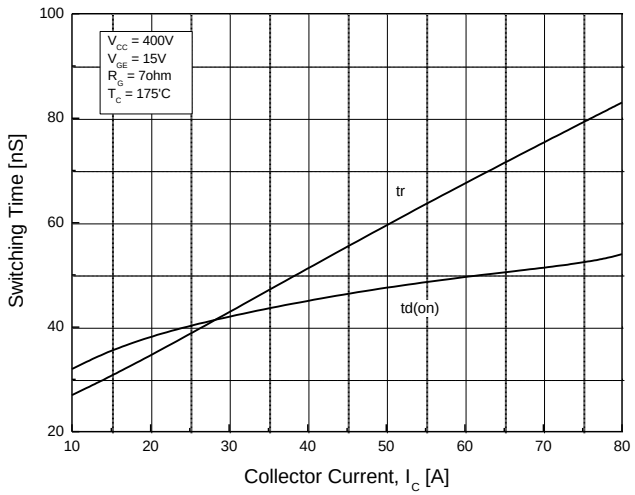

Fig.10 Typical Turn on-Collector Current

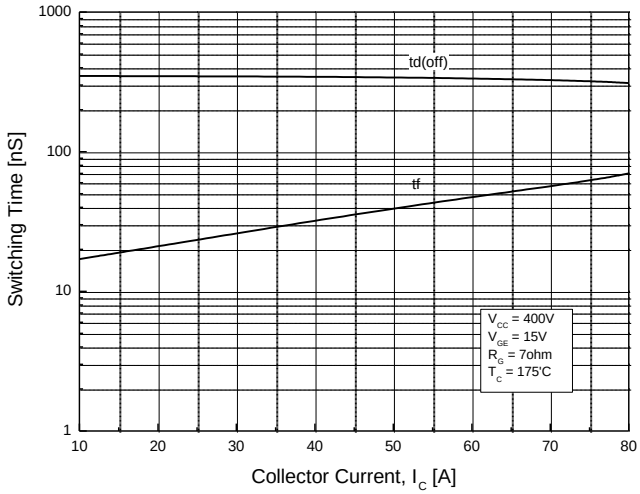

Fig.11 Typical Turn off-Collector Current

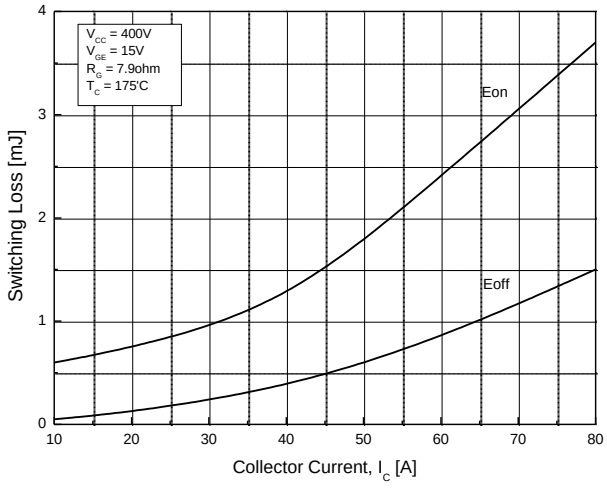

Fig.12 Switching Loss-Collector Current

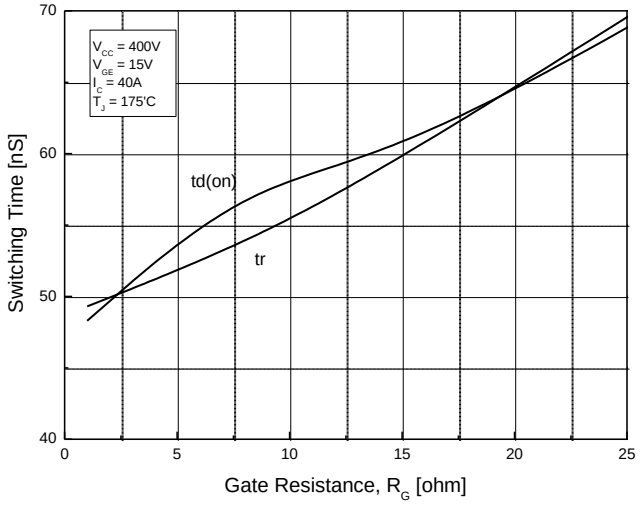

Fig.13 Turn on Characteristics-Gate Resistance

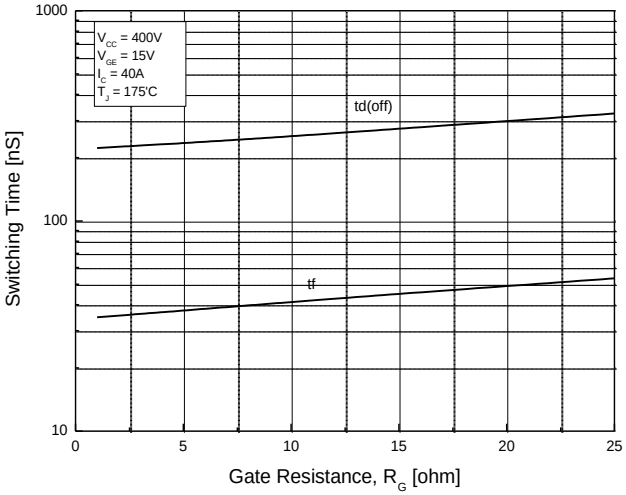

Fig.14 Turn off Characteristics-Gate Resistance

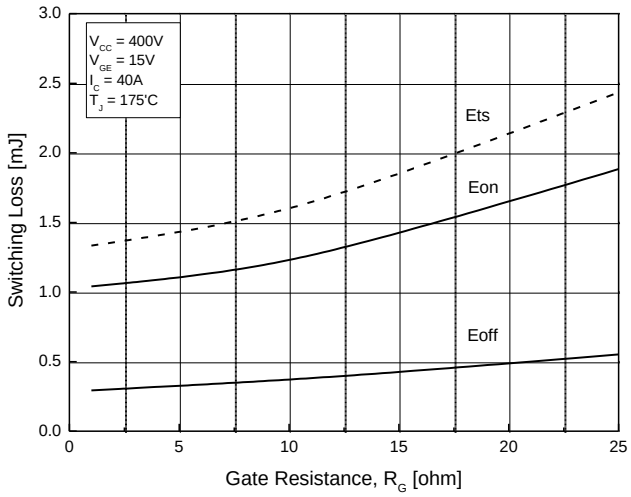

Fig.15 Switching Loss-Gate Resistance

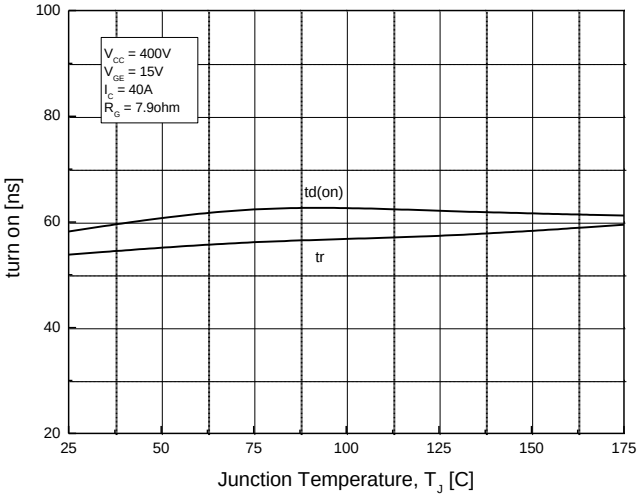

Fig.16 Turn on Characteristics -Junction Temperature

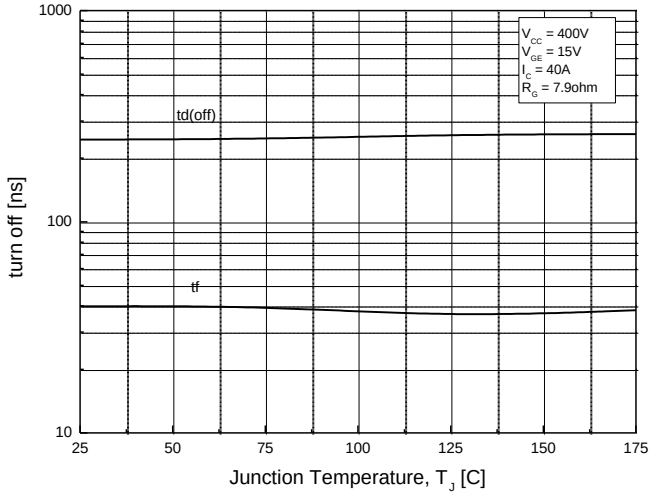

Fig.17 Turn off Characteristics -Junction Temperature

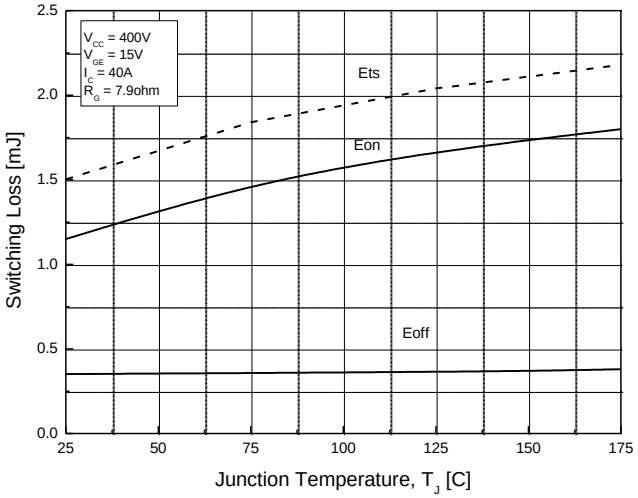

Fig.18 Switching Loss-Junction Temperature

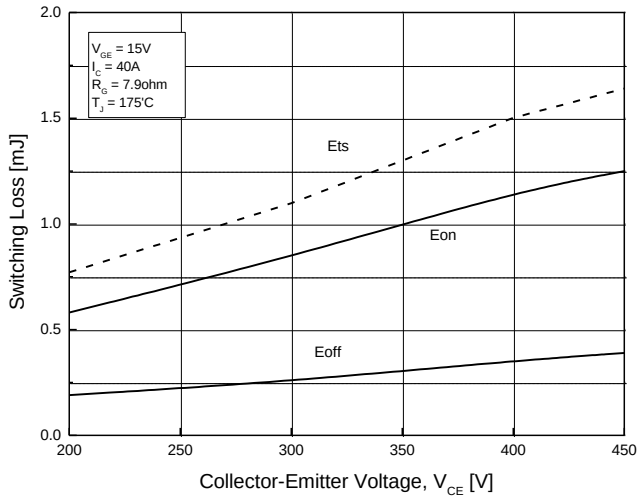

Fig.19 Switching Loss-Collector Emitter Voltage

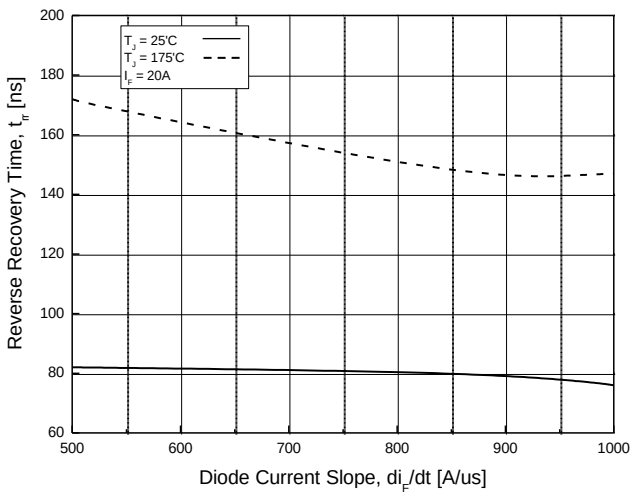

Fig.20 Reverse Recovery Time -Diode current slope

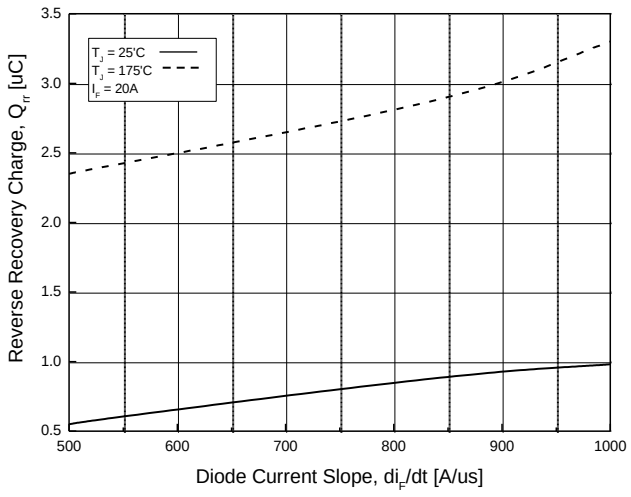

Fig.21 Reverse Recovery Charge -Diode Current Slope

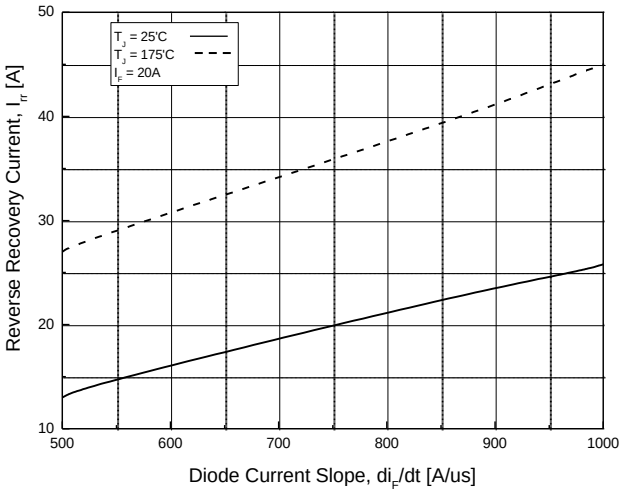

Fig.22 Reverse Recovery Current -Diode current slope

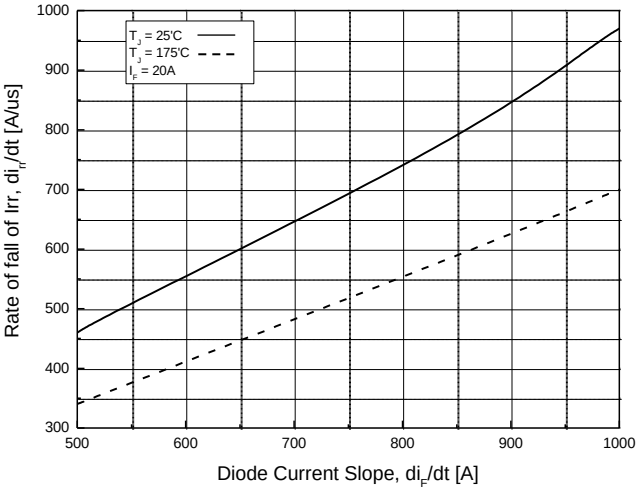

Fig.23 Rate of fall of reverse recovery current -Diode Current Slope

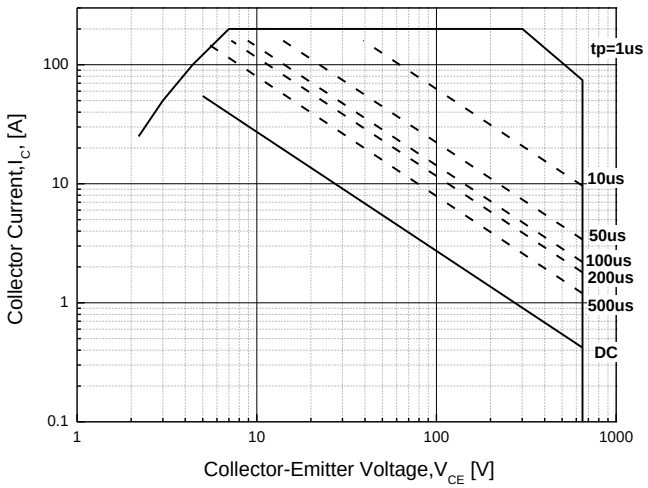

Fig.24 Forward Bias Safe Operating Area

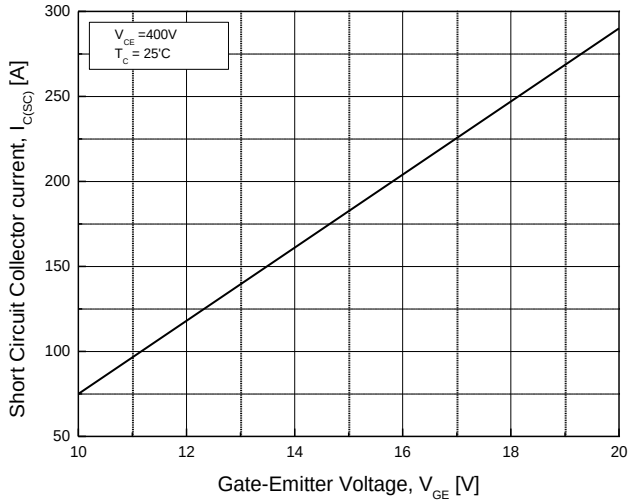

Fig.25 Typical Short Circuit Collector Current

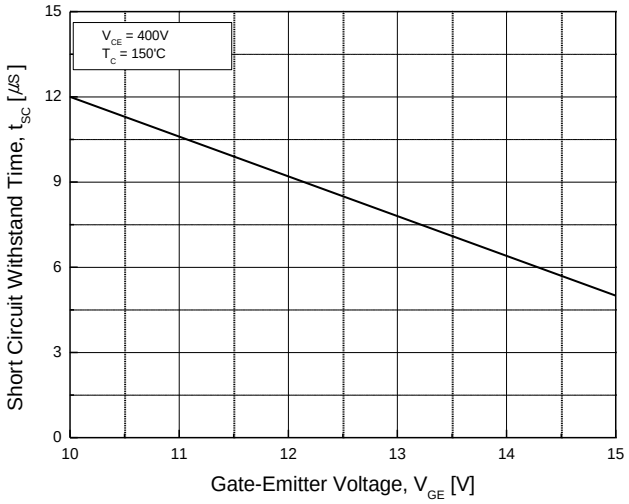

Fig.26 Typical Short Circuit Withstand Time

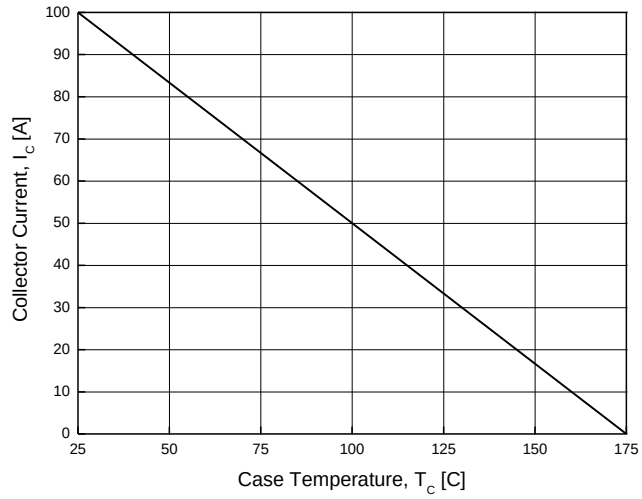

Fig.27 Case Temperature-Collector Current

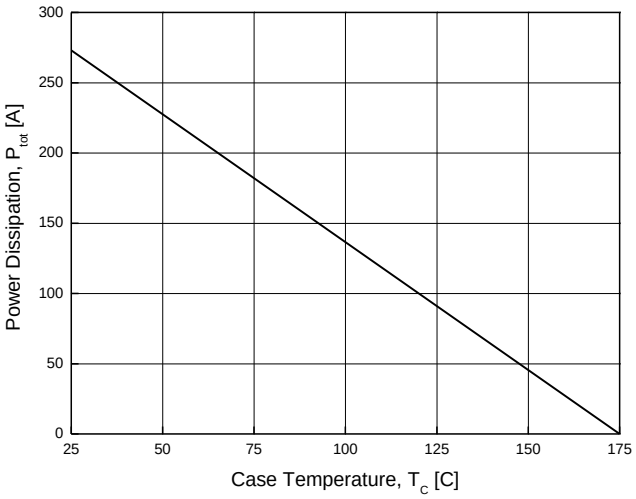

Fig.28 Power Dissipation-Case Temperature

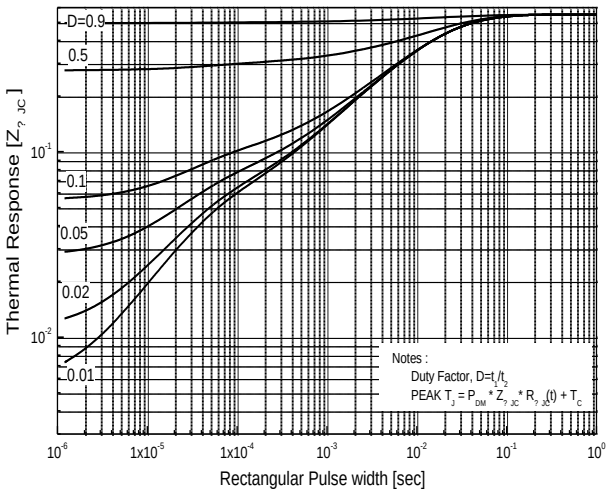

Fig.29 IGBT Transient Thermal Impedance

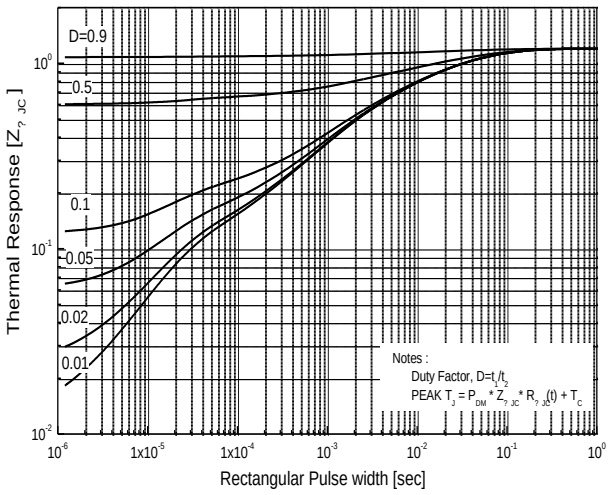

Fig.30 FRD Transient Thermal Impedance

Physical Dimension

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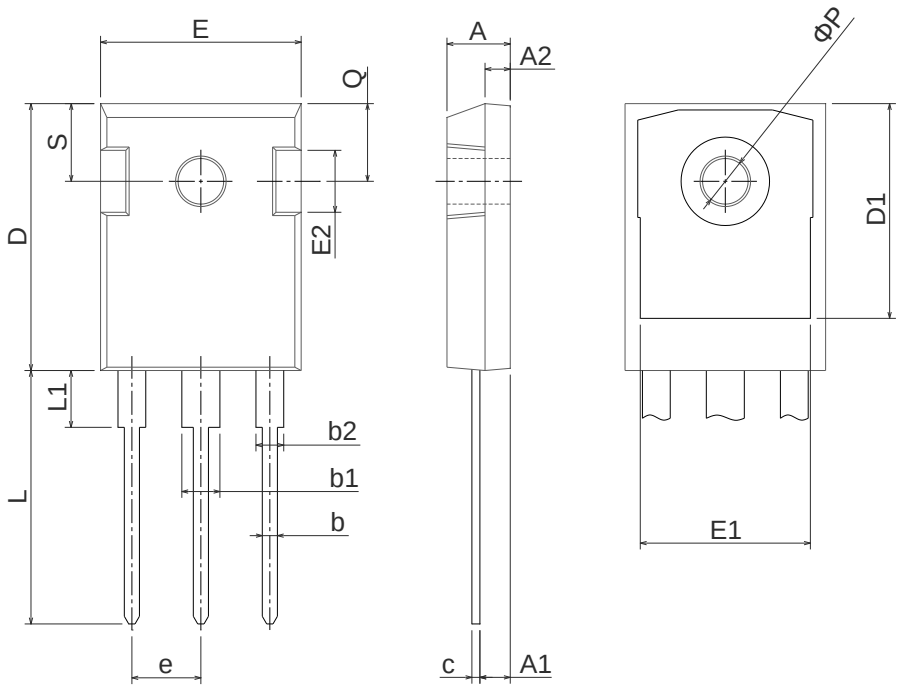
Dimensions are in millimeters, unless otherwise specified



Dimension	Min(mm)	Max(mm)
A	4.70	5.31
A1	2.20	2.60
A2	1.50	2.49
b	0.99	1.40
b1	2.59	3.43
b2	1.65	2.39
c	0.38	0.89
D	20.30	21.46
D1	13.08	-
E	15.45	16.26
E1	13.06	14.02
E2	4.32	5.49
e	5.45BSC	
L	19.81	20.57
L1	-	4.50
ΦP	3.50	3.70
Q	5.38	6.20
S	6.15BSC	

DISCLAIMER:

The Products are not designed for use in hostile environments, including, without limitation, aircraft, nuclear power generation, medical appliances, and devices or systems in which malfunction of any Product can reasonably be expected to result in a personal injury. Seller's customers using or selling Seller's products for use in such applications do so at their own risk and agree to fully defend and indemnify Seller.